

TEMA[®] (Technology and Management)



- Subject Coverage**
- Aerospace
 - Automotive research
 - Ceramics and plastics
 - Civil engineering
 - Electrical engineering and electronics
 - Energy
 - Information technology
 - Instrumentation
 - Machinery and plants
 - Management and organization
 - Manufacturing
 - Materials, metals, paints
 - Mechanical engineering
 - Medical engineering
 - Mining
 - Textile engineering
 - Transportation

File Type Bibliographic

Features

Thesaurus	None
Alerts (SDIs)	Not available
CAS Registry Number [®] Identifiers	<input type="checkbox"/>
Keep & Share	<input checked="" type="checkbox"/> SLART <input checked="" type="checkbox"/>
Learning Database	<input type="checkbox"/> Structures <input type="checkbox"/>

Record Content Bibliographic information, indexing, and an abstract, either in German, or English, partly also in both languages.

File Size 7,424,316 records (10/2023)

Coverage 1968 – 2021

Updates Static file

Language English, German

Database Producer WTI AG
Weidbrunnenstraße 2
8135 Langnau am Albis
Schweiz
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Copyright Holder

- Sources**
- Reports
 - Conferences
 - Journals
 - Dissertations
 - Patents
 - Standards
 - Translations
 - Books

- User Aids**
- WTI-Classification *
 - Online Helps (HELP DIRECTORY lists all help messages available)
 - STNGUIDE

* Available from producer

Cluster

- AEROTECH
- ALLBIB
- AUTHORS
- COMPUTER
- CONSTRUCTION
- CORPSOURCE
- ELECTRICAL
- ENGINEERING
- MATERIALS
- METALS
- NPS

STN Database Cluster information:

<https://www.cas.org/support/training/stn/database-clusters>

Search and Display Field Codes

Fields that allow left truncation are indicated by an asterisk (*).

Search Fields

Search Field Name	Search Code	Search Examples	Display Codes
Basic Index* (contains single words from abstract (AB), controlled term (CT), controlled term in German (CTDE), title (TI), supplementary term (ST), and uncontrolled term (UT) fields)	None or /BI	S ORGANISATIONSSTRUKTUREN(L) AUFTRAG? S MAPPING ALGORITHM# S SAFETY REGULATIONS S ?FILTRATION?	AB, CT, CTDE, ST, TI, UT
Abstract*	/AB	S FORMALDEHYDE/AB	AB
Accession Number	/AN	S 20030100009/AN	AN
Author	/AU	S MAN C H/AU S MAN, C H/AU	AU
Classification Code (1) (code and text)	/CC	S 3AAP/CC S PROJECT MANAGEMENT/CC	CC
Classification Code in German (1) (code and text)	/CCDE	S 3AAP/CCDE S PROJEKTMANAGEMENT/CCDE	CCDE
Corporate Source (1)	/CS	S MAN DIESEL AUGSBURG/CS	CS
Controlled Term	/CT	S SAFETY-RELAYS/CT	CT
Controlled Term in German	/CTDE	S MAC-OS/CTDE	CTDE
Controlled Word	/CW	S KNIT/CW	CT, CTDE
Document Number	/DN	S 20191222689/DN	DN
Document Type (code and text)	/DT (or /TC)	S BOOK/DT S B/DT	DT
Entry Date (2)	/ED (or /UP)	S ED=JUL 2020 AND PY=2020	ED
Digital Object Identifier	/FTDOI (or /DOI)	S HTTPS://DX.DOI.ORG/0.1557/OPL.2013.111/FTDOI	FTDOI, SO
International Standard (Document) Number (contains ISSN and ISBN)	/ISN	S 953-97026-6-6/ISN S 1090-8471/ISN	ISN, SO
Journal Title (contains full and abbreviated journal titles)	/JT	S JOURNAL OF ADHESION/JT	JT, JTA, JTF, SO
Language (ISO code and text)	/LA	S L1 AND ENGLISH/LA	LA
Meeting Date (1)	/MD	S MD=11 FEB 2020	MD
Meeting Location (2)	/ML	S DUESSELDORF/ML	ML
Meeting Title (2)	/MT	S SPRITZGIESSEN/MT	MT
Meeting Year (1)	/MY	S 2020/MY	MY
Publication Year (2)	/PY	S 1998-1999/PY	PY, SO
Publisher (1)	/PB	S SPRINGER BERLIN/PB	PB, SO
Source (contains journal titles, and other higher-level titles, serial titles, ISSN, ISBN, publisher, DOIs, URLs, and pagination)	/SO	S (ROENTGENSTRAHLEN AND 2001)/SO S 1438 9029/SO S DAS ECHO/SO	SO
Supplementary Term	/ST	S ANLAGENBAU/ST	ST
Title*	/TI	S ROUTE PLANNING/TI	TI
Update Date (1)	/UP	S ED>JUL 2020	UP
Uniform Resource Locator	/URL	S SPRINGERONLINE/URL	URL, SO

(1) Search with implied (S) proximity is available in this field.

(2) Numeric search field that may be searched with numeric operators or ranges.

Property Fields⁽¹⁾

In TEMA a numeric search for a specific set of physical properties (/PHP) is available within the text fields (TI, AB, BI). The numeric values are not displayed as single fields but highlighted within the hit displays.

EXPAND in the PHP field (e.g., => E A/PHP) to see all available physical properties. Use EXPAND/PHP to search for all available physical properties. A search with the respective field codes will be carried out in all database fields with English text. The /PHP index contains a complete list of codes and related text for all physical properties available for numeric search.

Field Code	Property	Unit	Symbol	Search Examples
/AOS	Amount of substance	Mol	mol	S 10 /AOS
/BIR	Bit Rate	Bit/Second	bit/s	S 8000-10000/BIR
/BIT	Stored Information	Bit	Bit	S BIT > 3 MEGABIT
/CAP	Capacitance	Farad	F	S 1-10 MF/CAP
/CATA	Catalytic Activity	Katal	kat	S 1-10/CATA
/CDN	Current Density	Ampere/Square Meter	A/m ²	S CDN>10 A/M**2
/CMOL	Molarity, Molar Concentration	Mol/Liter	mol/L	S UREA/BI (S) 8/CMOL
/CON	Conductance	Siemens	S	S 1S-3/CON
/DB	Decibel	Decibel	dB	S DB>50
/DEG	Degree	Degree	°	S CYLINDER/BI (S) 45/DEG
/DEN (/C)	Density (Mass Concentration)	Kilogram/Cubic Meter	kg/m ³	S 5E-3-10E-3/DEN
/DEQ	Dose Equivalent	Sievert	Sv	S 100/DEQ
/DOA	Dosage	Milligram/Kilogram/Day	mg/day	S 100-300/DOA
/DOS (/LD50)	Dose	Milligram/Kilogram	mg/kg	S DOS>0.8
/DV	Viscosity, dynamic	Pascal * Second	Pa * s	S DV>5000
/ECH (/CHA)	Electric Charge	Coulomb	C	S 0.0001-0.001/ECH
/ECO (/ECND)	Electrical Conductivity	Siemens/Meter	S/m	S ECO>800 S/M (15A) AQUEOUS
/ELC (/ECC)	Electric Current	Ampere	A	S 1-10/ELC
/ELF (/ECF)	Electric Field	Volt/Meter	V/m	S 200/ELF
/ENE	Energy	Joule	J	S DROPLETS (10A) 40 JOULE - 70 JOULE /ENE
/ERE (/ERES)	Electrical Resistivity	Ohm * Meter	Ohm * m	S ERE>0.1
/FOR	Force	Newton	N	S 50 N /FOR
/FRE (/F)	Frequency	Hertz	Hz	S OSCILLAT?/BI (S) 1- 3/FRE
/IU	International Unit	none	IU	S IU>1000 (P) VITAMIN A
/KV	Viscosity, kinematic	Square Meter/Second	m ² /s	S METHYLPOLYSILOXANES/BI (10A) 200-300 CST /KV
/LEN (/SIZ)	Length, Size	Meter	m	S 1-4/LEN
/LUME	Luminous Emittance, Illuminance	Lux	lx	S 10-50/LUME
/LUMF	Luminous Flux	Lumen	Lm	S LUMF>1000
/LUMI	Luminous Intensity	Candela	cd	S LUMI<4
/M	Mass	Kilogram	kg	S ALLOY/BI (30A) 1E-10-1E-5/M
/MCH	Mass to Charge Ratio	none	m/z	S MCH=1
/MFD (/MFS)	Magnetic Flux	Tesla	T	S MFD>102
/MFR (/MFL)	Density	Kilogram/Second	kg/s	S MFR<0.1
/MFST	Mass Flow Rate	Kilogram/Second	kg/s	
	Magnetic Field Strength	Ampere/Meter	A/m	

Property Fields (cont'd)

Field Code	Property	Unit	Symbol	Search Examples
/MM (/MW, /MOM)	Molar Mass	Gram/Mol	g/mol	S 2000-3000 G/MOL/MM
/MOLS	Molality of Substance	Mol/Kilogram	mol/kg	S 01.-10 MOL/KG/MOLS
/MVR	Melt Volume Rate, Melt Flow Rate	none	g/10 min	S 3/MVR
/PER	Percent (Proportionality)	none	%	S POLYMER?/AB (5A) 4/PER
/PHV (/PH)	pH Value	pH	pH	S 7.4-7.6/PHV
/POW (/PW)	Power	Watt	W	S "HG-XE-?"/BI (S) 100-200 WATT/POW
/PPM	Parts per million	Ppm	ppm	S 100 PPM /PPM (10A) ADDITIVE/BI
/PRES (/P)	Pressure	Pascal	Pa	S (VACUUM (5A) DISTILL?)/BI (S) 1000-1100/PRES
/RAD	Radioactivity	Becquerel	Bq	S RAD/PHP
/RES	Electrical Resistance	Ohm	Ohm	S SENSOR /BI (S) 10- 100/RES
/RI	Refractive Index	none		S 3-4/RI
/RSP	Rotational Speed	Revolution/Minute	rpm	S 2 RPM - 100 RPM /RSP (S) ENGINE/BI
/SAR	Area /Surface Area	Square Meter	m ²	S PLATE/BI (S) 10 M**2 - 100 M**2 /SAR
/SOL (/SLB)	Solubility	Gram/100 gram	g/100 g	S SOL>20 G/100G (5A) WATER
/SSAM	Specific Surface Area, Mass	Square Meter/Kilogram	M ² /kg	S 1-10/SSAM
/STSC (/ST)	Surface Tension	Joule /Square Meter	J/m ²	S 60 J/M**2/STSC
/TCO (/TCND)	Thermal Conductivity	Watt/Meter * Kelvin	W/m * K	S 1/TCO (S) HEAT?
/TEMP (/T)	Temperature	Kelvin	K	S 20-25/TEMP
/TEX	Tex	Gram/Kilometer	g/km	
/TIM	Time	Second	s	S ?INCUB?/BI (10A) 50 S - 150 S /TIM
/VEL (/V)	Velocity	Meter per Second	m/s	S REDUC?/BI (S) 1E-3-5E-3/VEL
/VELA	Velocity, angular	Radian/Second	rad/s	S VELA>10
/VLR	Volumetric Flow Rate	Cubic Meter/Second	m ³ /s	S 1 M**3/S - 2 M**3/S /VLR (S) ABRASIVE
/VOL	Volume	Cubic Meter	m ³	S 1E-8-2E-8/VOL.EX
/VOLT	Voltage	Volt	V	S TENSION/BI (10A) 5E-3 V <VOLT<7E-3 V

(1) Exponential format is recommended for the search of particularly high or low values, e.g., 1.8E+7 or 1.8E7 (for 18000000) or 9.2E-8 (for 0.000000092).

DISPLAY and PRINT Formats

Any combination of formats may be used to display or print answers. Multiple codes must be separated by spaces or commas, e.g., D L1 1-5 TI AU. The fields are displayed or printed in the order requested.

Hit term highlighting is available for all fields. Highlighting must be ON during SEARCH to use the HIT, KWIC, and OCC formats.

Format	Content	Examples
AB AN AU CC (1) CCDE (1) CS CT CTDE DN DT (TC) FTDOI ISN (1) JT (1) JTF (1) LA MD (1) ML (1) MT (1) MY (1) PB (1) PY (1) SO ST TI UP (ED) (1) URL UT	Abstract Accession Number Author Classification Code Classification Code in German Corporate Source Controlled Term Controlled Term in German Document Number Document Type Digital Object Identifier International Standard (Document) Number Journal Title Journal Title, Full Language Meeting Date Meeting Location Meeting Title Meeting Year Publisher Publication Year Source Supplementary Term Title Update Date Uniform Resource Locator Uncontrolled Term	D AB D AN D AU TI D CC D CCDE D CS D CT D CTDE D DN D DT D FTDOI D ISN D JT D JTF D LA D MD D ML D MT D MY D PB D PY D SO D ST D TI D UP D URL D UT
ABS ALL ALLDE DALL IALL BIB (STD) IBIB IND INDDE SCAN (2) TRIAL (FREE, TRI, SAMPLE, SAM)	AN, AB AN, DN, TI, AU, CS, SO, DT, AV, LA, ED, AB, CC, CT, ST, UT AN, DN, TI, AU, CS, SO, DT, AV, LA, ED, AB, CCDE, CTDE, ST, UT ALL, delimited for post-processing ALL, indented with text labels AN, DN, TI, AU, CS, SO, DT, AV, LA, ED (BIB is default) BIB, indented with text labels AN, CC, CT, ST, UT AN, CCDE, CTDE, ST, UT TI, CT (random display without answer numbers) TI, CC, CT, ST, UT	D ABS D ALL D DALL D IALL D BIB D IBIB D IND D INDDE D SCAN D TRIAL
HIT KWIC OCC	Hit term(s) and field(s) Up to 50 words before and after hit term(s) (KeyWord-In-Context) Number of occurrences of hit term(s) and field(s) in which they occur	HIT KWIC OCC

(1) Custom display only.

(2) SCAN must be specified on the command line, i.e., D SCAN or DISPLAY SCAN

SELECT, ANALYZE, and SORT Fields

The SELECT command is used to create E-numbers containing terms taken from the specified field in an answer set.

The ANALYZE command is used to create an L-number containing terms taken from the specified field in an answer set.

The SORT command is used to rearrange the search results in either alphabetic or numeric order of the specified field(s).

Field Name	Field Code	ANALYZE/ SELECT (1)	SORT
Abstract	AB	Y (2)	N
Accession Number	AN	Y	N
Author	AU	Y	Y
Classification Code	CC	Y	Y
Classification Code in German	CCDE	Y	Y
Citation	CIT	Y (3,4)	N
Controlled Term	CT	Y	N
Controlled Term in German	CTDE	Y	Y
Corporate Source	CS	Y	Y
Digital Object Identifier	FTDOI (DOI)	Y	Y
Document Number	DN	Y	Y
Document Type	DT (TC)	Y	Y
Entry Date	ED	Y	Y
International Standard Book Number	ISBN	N	Y
International Standard (Document) Number	ISN	Y (5)	Y
Journal Title	JT	Y	Y
Language	LA	Y	Y
Meeting Date	MD	Y	Y
Meeting Location	ML	Y	Y
Meeting Title	MT	Y	Y
Meeting Year	MY	Y	Y
Occurrence Count of Hit Terms	OCC	N	Y
Publisher	PB	Y	Y
Publication Year	PY	Y	Y
Source	SO	Y (6)	Y
Supplementary Term	ST	Y	Y
Title	TI	Y (default)	Y
Update Date	UP	Y	Y
Uniform Resource Locator	URL	Y	Y
Uncontrolled Term	UT	Y (2,4)	Y

(1) Hit may be used to restrict extracted terms to terms that match the search expression used to create the answer set, e.g., SEL HIT TI.

(2) Appends /BI to the terms created by SELECT.

(3) SELECT or ANALYZE CIT allows you to extract the reference from the source documents in this file and have them automatically converted to a citation format for searching in the SCISEARCH file. SEL or ANALYZE CIT extracts first author, publication year, volume, first page, with a truncation symbol and with /RE appended to the terms created by SELECT.

(4) SELECT HIT or ANALYZE HIT is not valid with this field.

(5) Selects ISBN and ISN with /SO appended to the terms created by SELECT.

(6) Selects ISBN and ISSN with /SO appended to the terms created by SELECT.

Sample Records

DISPLAY BIB OF CONFERENCE

AN 20200175262 TEMA
 DN 20200700099
 TI Rolling into the Future - Bearing Solutions for Electric Mobility
 Waelzlagerloesungen fuer die E-Mobilitaet
 AU Voelkel, Franz; Tietz, Manfred; Schamin, Alexander; Giehl, Sebastian
 CS Schaeffler Technologies, Herzogenaurach, DE
 SO Dritev, International VDI Congress Dritev - Drivetrain for Vehicles, 20;
 VDI-Berichte (2020), Volume 2373, pp. 103-117, 15 Seiten, 6 Quellen
 ISSN: 0083-5560 ISBN: 978-3-18-092373-4
 Published by: VDI-Verlag, Duesseldorf, <http://www.vdi-verlag.de>
 Conference: International VDI Congress Dritev - Drivetrain for Vehicles,
 20th, Bonn, DE, 24 Jun 2020 - 25 Jun 2020
 DT Conference; Conference Article
 LA English
 ED Entered STN: 23 Jul 2020
 Last updated on STN: 23 Jul 2020

DISPLAY ALL OF JOURNAL

AN 20200175396 TEMA
 DN 20200700233
 TI Development of a Resistance Spot Welding Process Using Additive
 Manufacturing
 AU Batista, Marcio; Furlanetto, Valdir; Brandi, Sergio Duarte
 CS Universidade de Sao Paulo (USP), BR; Welding Science, Sao Paulo, BR
 SO Metals (2020), Volume 10, Number 5, pp. 555/1-555/12, 12 Seiten, 22
 Quellen
 ISSN: 2075-4701
 DOI: <https://dx.doi.org/10.3390/met10050555>
 Published by: MDPI AG, Basel, <http://www.mdpi.com>
 URL (Document): <https://www.mdpi.com/2075-4701/10/5>
 DT Journal
 LA English
 ED Entered STN: 23 Jul 2020
 Last updated on STN: 23 Jul 2020
 AB For several decades, the electrical resistance spot welding process has
 been widely used in the manufacturing of sheet metal structures,
 especially in automotive bodies. During this period there was no
 significant development for this welding process. However, in recent
 years, in order to meet the demand for lighter, economical, and low-cost
 vehicles, the automotive manufacturing industry is undergoing a
 revolution in the use of high strength steel sheet combinations, chemical
 compositions, and of different thicknesses. In this context, the present
 work focuses on the study and development of a new resistant spot welding
 technology using additive manufacturing (AMSW) in
 zinc-coated steel sheets, used in the automotive industry. As a
 comparison, spot welding was also performed by the conventional
 resistance spot welding process (RSW). The results showed that the spot
 welding process using additive manufacturing (AMSW), through the
 optimized parameters, compared to the conventional resistance spot
 welding process (RSW), was 34.47% higher in relation to the shear
 tensile stress, as well as 28.57% higher tensile stress with a
 perpendicular load to the weld spot. The indentation or thermomechanical
 mark on the surface of the sheet was imperceptible to the visual
 inspection, producing a smooth face in the spot region.
 CC 3LNB Welding, soldering; 3KEB Steels, cast steel; 3KX Materials
 properties

CT SPOT-WELDING; ADDITIVE-MANUFACTURING; AUTOMOBILE-INDUSTRY; PRESSING-IN;
PRESSING-IN; ASSESSING; TENSILE-STRESS; WELDING-TECHNIQUE; WELD-POINT;
VALUE-OF-ELECTRIC-RESISTANCE; SHEET-METALS; HIGH-STRENGTH-STEEL;
CHEMICAL-COMPOSITION; ZINC; COATED-STEEL; OPTIMIZATION-PARAMETER;
BODY:VEHICLE

ST Punktschweissen; additive Fertigung; Automobilindustrie;
Schweisssverfahren; Eindrueckung; visuelle Inspektion; Zugspannung;
Schweisstechnologie; Schweißpunkt; elektrischer Widerstand (Wert);
Blech; hochfester Stahl; chemische Zusammensetzung; Zink; beschichteter
Stahl; Optimierungsparameter; Karosserie

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